

MR2000 SERIES

High-reliability discrete products and engineering services since 1977

MEDIUM CURRENT SILICON RECTIFIERS

FEATURES

- Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.
- Available as non-RoHS (Sn/Pb plating), standard, and as RoHS by adding "-PBF" suffix.

MAXIMUM RATINGS

Ratings	Symbol	MR 2000	MR 2001	MR 2002	MR 2004	MR 2006	MR 2008	MR 2010	Unit
Peak repetitive reverse voltage	V _{RRM}								
Working peak reverse voltage	V _{RWM}	50	100	200	400	600	800	1000	Volts
DC blocking voltage	V _R								
Non-repetitive peak reverse voltage	N	()	120	240	400	720	000	1200	Valta
(half-wave, single phase, 60Hz peak)	VRSM	60	120	240	480	720	960	1200	VOITS
RMS forward current	I _(RMS)	40			Amps				
Average rectified forward current	20				Amos				
(single phase, resistive load, 60Hz, $T_c = 150^{\circ}C$)	I ₀	1 ₀ 20				Amps			
Non-repetitive peak surge current									
(surge applied @ rated load conditions, half wave, single phase, 60Hz)	I _{FSM}	400(1 cycle)				Amps			
Operating and storage temperature range	T _J , T _{stg}	-65 to +175			°C				
Maximum thermal resistance, junction to case	R _{ejc}	1.3			°C/W				

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

Characteristic	Symbol	Maximum	Unit
Maximum instantaneous forward voltage	V	1 1	Volte
(I _F = 63A, T _C = 25°C)	VF	1.1	VOILS
Maximum reverse current (rated dc voltage)			
T _c = 25°C	I _R	100	μΑ
$T_c = 100^{\circ}C$		500	



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MECHANICAL CHARACTERISTICS

Case	DO-4(R)	
Marking	Alpha-numeric	
Normal polarity	Cathode is stud	
Reverse polarity	Anode is stud (add "R" suffix)	



	DO-4(R)						
	Inches		Millim	neters			
	Min	Max	Min	Max			
Α	-	0.078	-	1.981			
В	0.422	0.453	10.719	11.506			
С	-	0.405	-	10.287			
D	-	0.800	-	20.320			
Е	0.420	0.440	10.668	11.176			
F	-	0.250	-	6.350			
G	-	0.424	-	10.770			
Н	0.066	-	1.676	-			



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FIGURE 2 - NON-REPETITIVE SURGE CURRENT



FIGURE 3 - FORWARD VOLTAGE TEMPERATURE COEFFICIENT



40 IF(AV), AVERAGE FORWARD CURRENT (AMP) dc I<u>(FM)</u> 2 (SQUARE WAVE) KAV) (FM) # (SINEWAVE RESISTIVE LOAD) 32 2 0 24 50 16 10 20 = 8 0 CAPACITIVE LOADS D 125 130 135 140 145 150 155 160 165 170 175 TC, CASE TEMPERATURE (°C)

FIGURE 4 - CURRENT DERATING



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FIGURE 5 - FORWARD POWER DISSIPATION 40 TJ = 175°C



FIGURE 6 - THERMAL RESPONSE





Duty cycle = $D = t_p/t_1$ Peak power $= P_{pk}$ is peak of an equivalent square power pulse

To determine maximum junction temperature of the diode in a given situation the following procedure is recommended: The temperature of the case should be measured using a thermocouple placed on the case at the temperature reference point. The thermal mass connected to the case is normally large enough so that it will not significantly respond to heat surges generated in the diode as a result of pulsed operation once steady state conditions are achieved. Using the measured value of T_C the junction temperature may be determined by: $T_J = T_C + \Delta T_{JC}$, where ΔT_{JC} is the increase in junction temperature above the case temperature. It may be determined by $\Delta T_{JC} = P_{pk} \bullet R_{oJC} [D + (1-D) \bullet r(t_r + t_p) - r(t_1)]$ where r(t) = normalized value of transient

thermal resistance at time t from figure 6, and $r(t_1+t_p)$ = normalized value of transient thermal resistance at time t_1+t_p .



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FIGURE 9 - REVERSE RECOVERY TIME



FIGURE 8 - FORWARD RECOVERY TIME



FIGURE 10 - RECTIFICATION WAVEFORM EFFICIENCY





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FIGURE 11 - SINGLE-PHASE HALF-WAVE RECTIFIER CIRCUIT



The rectification efficiency factor σ shown in Figure 10 was calculated using the formula:

$$\sigma = \frac{P_{dc}}{P_{rms}} = \frac{\frac{V^2_{O}(dc)}{R_{L}}}{\frac{V^2_{O}(rms)}{R_{L}}} \bullet 100\% = \frac{V^2_{O}(dc)}{V^2_{O}(ac) + V^2_{O}(dc)} \bullet 100\% \quad (1)$$

For a sine wave input V_m sin $\{\omega t\}$ to the diode, assume lossless, the maximum theoretical efficiency factor becomes

$$\sigma_{(\text{sine})} = \frac{\frac{\sqrt{2}m}{\pi^2 R_{\text{L}}}}{\frac{\sqrt{2}m}{4R_{\text{L}}}} + 100\% = \frac{4}{\pi^2} + 100\% = 40.6\%$$
(2)

For a square wave input of amplitude $V_{\mbox{m}}$, the efficiency factor becomes:

$$\sigma(\text{square}) = \frac{\frac{\nabla^2 m}{2R_L}}{\frac{\nabla^2 m}{R_L}} = 100\% = 50\%$$
(3)

(A full wave circuit has twice these efficiencies)

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As the frequency of the input signal is increased, the reverse recovery time of the diode (figure 9) becomes significant, resulting in an increasing ac voltage component across R_L which is opposite in polarity to the forward current, thereby reducing the value of the efficiency factor, σ , as shown in figure 10. It should be emphasized that figure 10 shows waveform efficiency only; it does not provide a measure of diode losses. Data was obtained by measuring the ac component of V_O with a true rms ac voltmeter and the dc component with a dc voltmeter. The data was used in Equation 1 to obtain points for figure 10.